



CASR

FAA Center for Aviation Systems Reliability

Summary of Developer Chamber Characterization

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<http://www.cnde.iastate.edu/faa-casr/fpi/index.html>



- 1999 – 2002 – Cleaning and Drying Studies performed as part of the Engine Titanium Consortium
- 2002 – 2006 – Engineering Assessment of Fluorescent Penetrant Inspection performed as part of Center for Aviation Systems Reliability effort



- Provide engineering data to support decisions regarding the safe application and relevant use of FPI
- Includes data to support changes in specifications
- Generate tools for use by airlines and OEMS that improve FPI processes
- Strong industry team with extensive experience



IOWA STATE UNIVERSITY
OF SCIENCE AND TECHNOLOGY



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Program Partners



Cooperative university/industry program which brings together aircraft and engine OEMs, airlines, vendors, as well as technical expertise from the NDE community.

ISU: Lisa Brasche, Rick Lopez, Bill Meeker
FAA: Al Broz, Paul Swindell, Dave Galella

Industrial Advisory Panel

Boeing - Long Beach

Dwight Wilson, John Petty

Boeing - Seattle

Steve Younker

Delta Airlines - Atlanta

Lee Clements

United Airlines - Indianapolis

Tom Dreher

Pratt & Whitney - EH and WPB

Kevin Smith, John Lively, Pete Ozga

Rolls Royce - Indianapolis and Darby

Pramod Khandelwal, Keith Griffiths,

Bill Griffiths

GE Aircraft Engines

Terry Kessler, Thadd Patton, Wayne Kitchen

Sherwin - Cincinnati

Sam Robinson

D&W Enterprises - Denver

Ward Rummel



- Define factors for which engineering data is deficient
 - Change in process, e.g., environmental changes
 - Change in applications
 - Data not available in the public domain
- Design engineering study that provides quantitative assessment of performance
 - Brightness measurements
 - Digital recording of UVA indication
 - Probability of Detection
- Complete study using either lab or shop facilities as appropriate
- Distribute results through use of web
- Support changes to industry specifications as warranted
- Utilize results to update/create guidance materials
- Transition process to airlines for internal, self-assessment

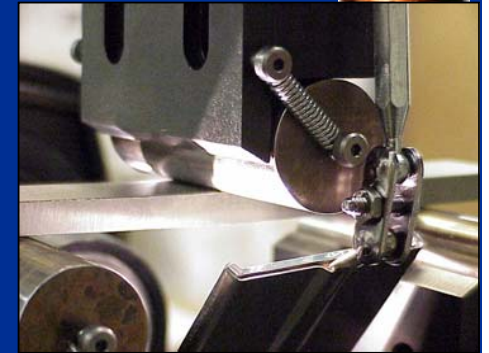
<http://www.cnde.iastate.edu/faa-casr/fpi/index.html>



- Titanium 6Al-4V
 - 1/4 and 1/2 inch thick plate
 - ASTM-B-265, Grade 5 and AMS 4911
- Inconel 718
 - 1/2 inch thick plate
 - AMS 5596
- EDM notches used as starter notches
- Three point bending to generate cracks with 2:1 to 3:1 crack aspect ratio
- Crack sizes ranging from 20 to 180 mils, most at 80 mils



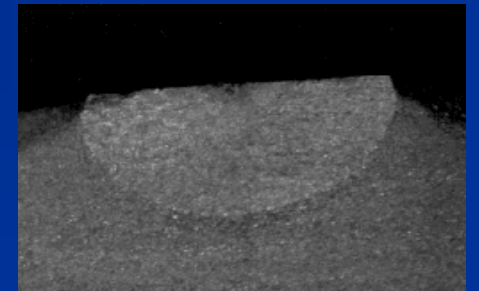
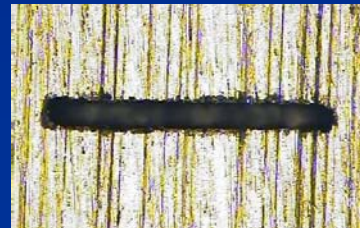
(a)



(b)

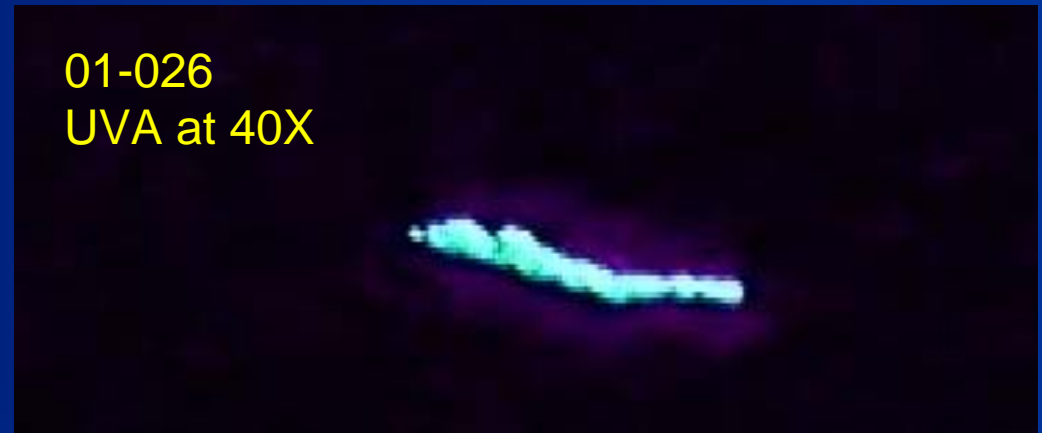


(c)





- Final surface polish to 32 Ra
- Optical photographs (100X digital)
- Brightness measurements and UVA image capture to establish baseline and remove samples that showed variability



(a)

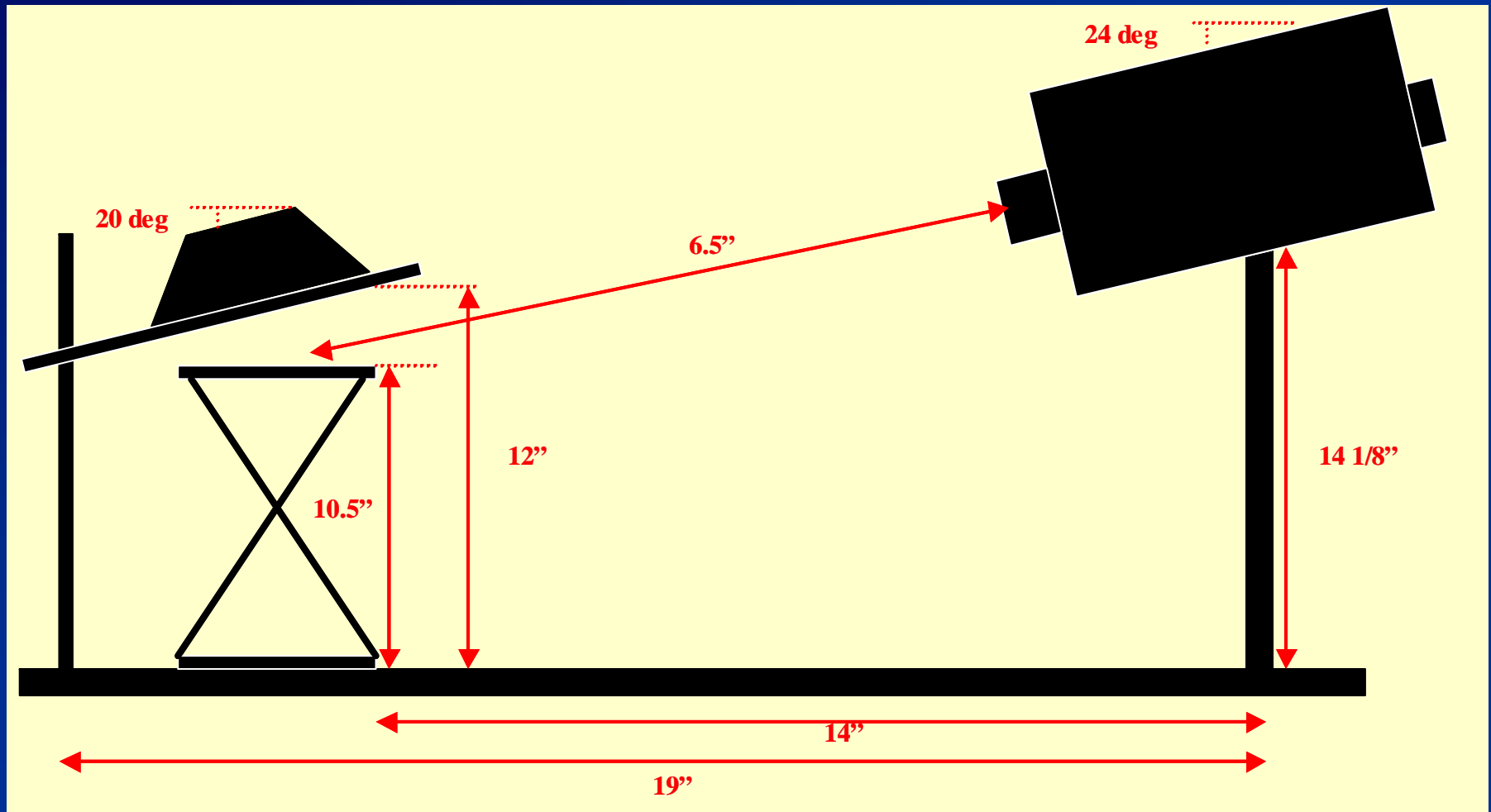


(b)



- Used rigid fixturing to assure repeatability with transportability for brightness measurements
- Photo Research PR-880 Photometer used to record indication brightness in ft-Lamberts







- Requires access to typical drying, cleaning and FPI methods used in commercial aviation
- Several partners have provided access to their facilities
 - Access to cleaning lines for Ti and Ni as well as mechanical blasting facilities
 - FPI line for sample processing
 - Inspection booth for characterization and brightness measurements





- 15 - 20 samples per basket
- 20 minute penetrant dwell
- 90 second pre-wash
- 120 seconds emulsifier contact with vertical motion
- Two 30 second cycles of air agitated water rinse, then a 90 second post-wash





- Samples dried for 8 minutes at 150°F
- Drag-through application of developer
- 10 minute development time
- Brightness reading using Spotmeter
- Length reading using UVA and image analysis software

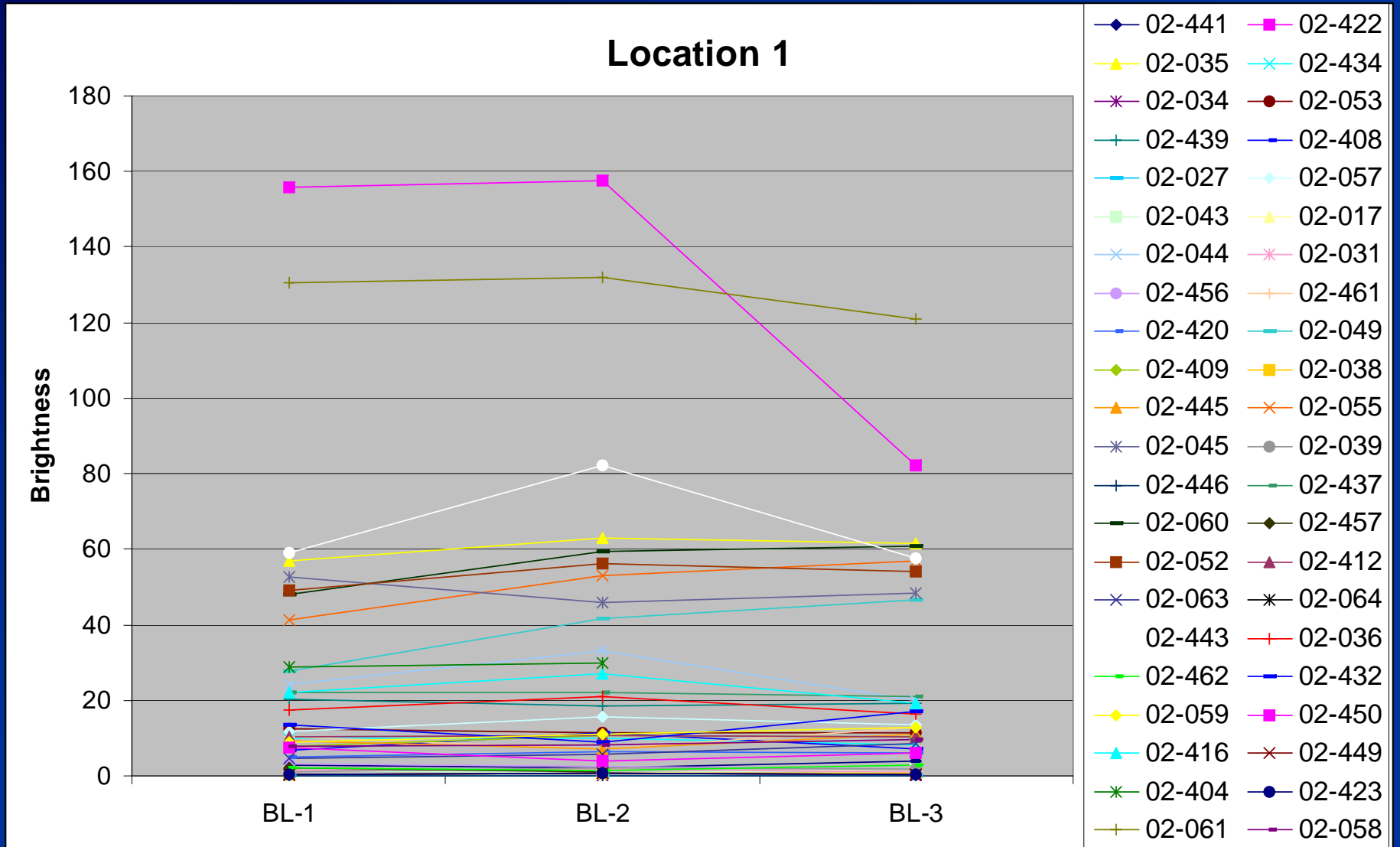


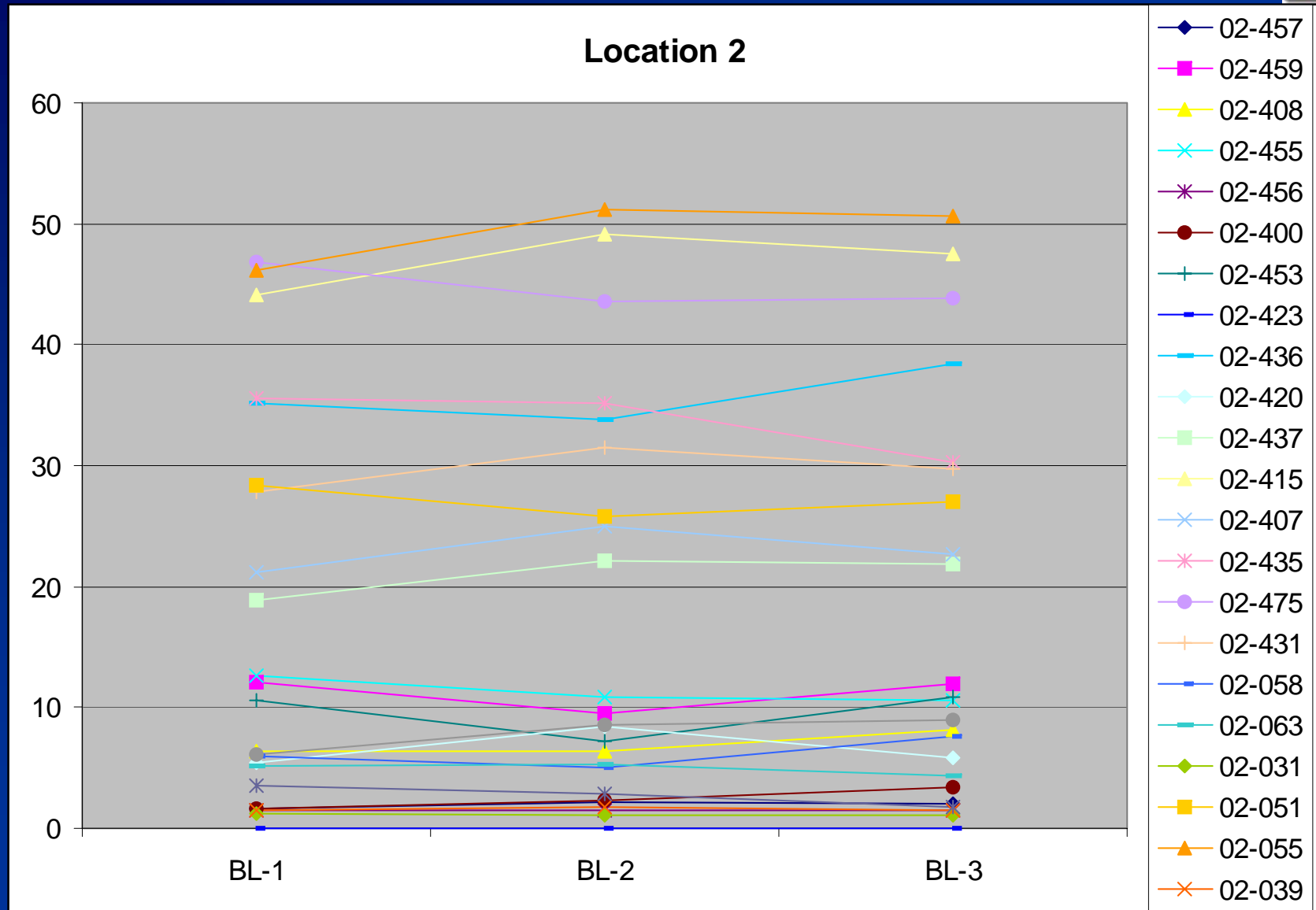


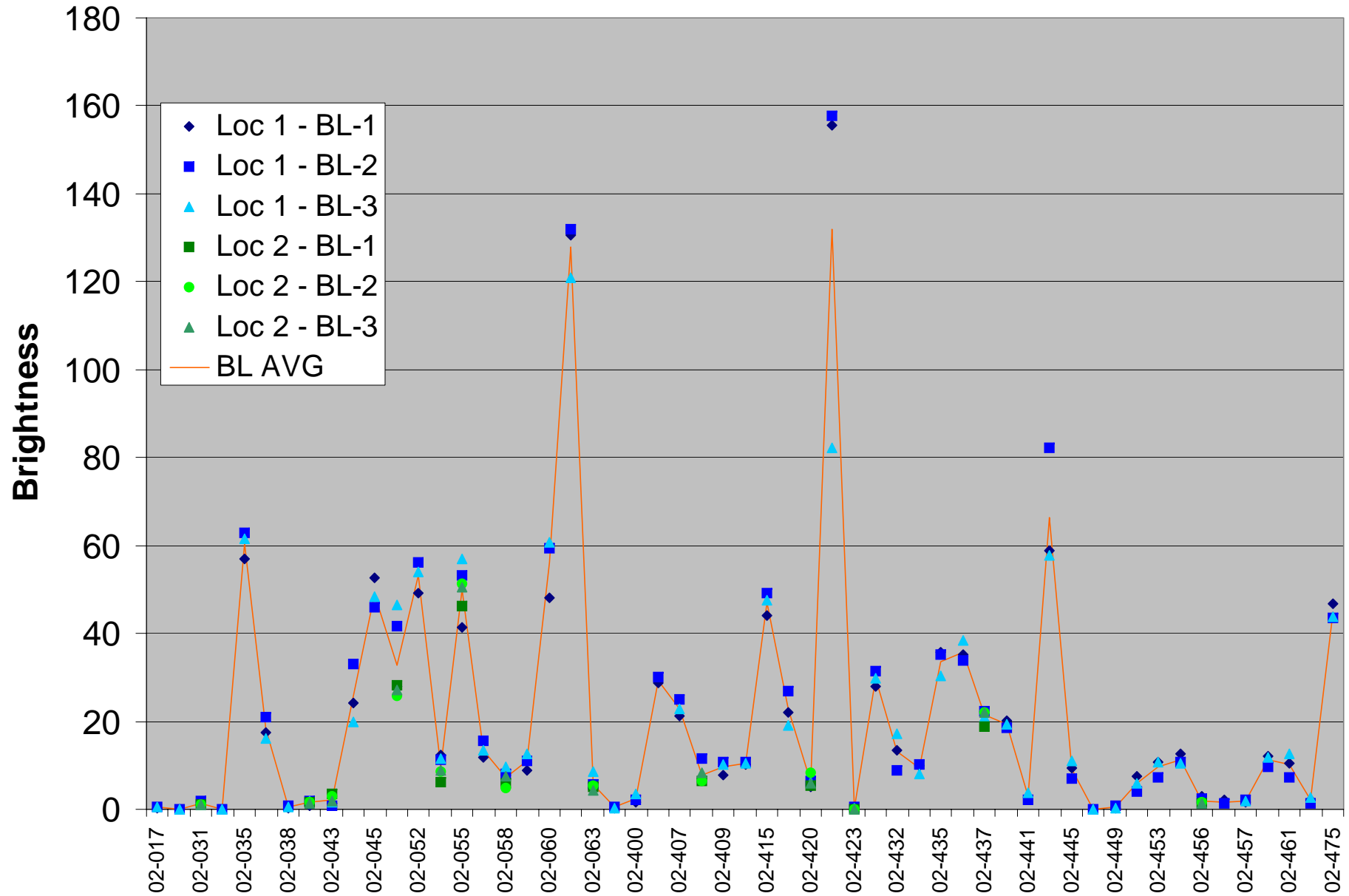
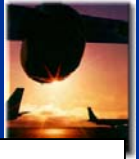
- Topics for engineering studies selected and prioritized by team
 - Subteams developed for experimental design with review by the full team
 - Experimental efforts to take place at various industry locations
 - Definition currently underway
- ES – 1 – Developer Studies
 - ES – 2 – Cleaning Studies for Ti, Ni and Al
 - ES – 3 – Stress Studies
 - ES – 4 – Assessment tool for dryness and cleanliness
 - ES – 5 – Effect of surface treatments on detectability
 - ES – 6 – Light level Studies
 - ES – 7 – Detectability Studies
 - ES – 8 – Study of Prewash and Emulsification Parameters
 - ES – 9 – Evaluation of Drying Temperatures
 - ES – 10 – Part geometry effects
 - ES – 11 – Penetrant Application Studies
 - ES – 12 – Relationship of part thickness to drying method

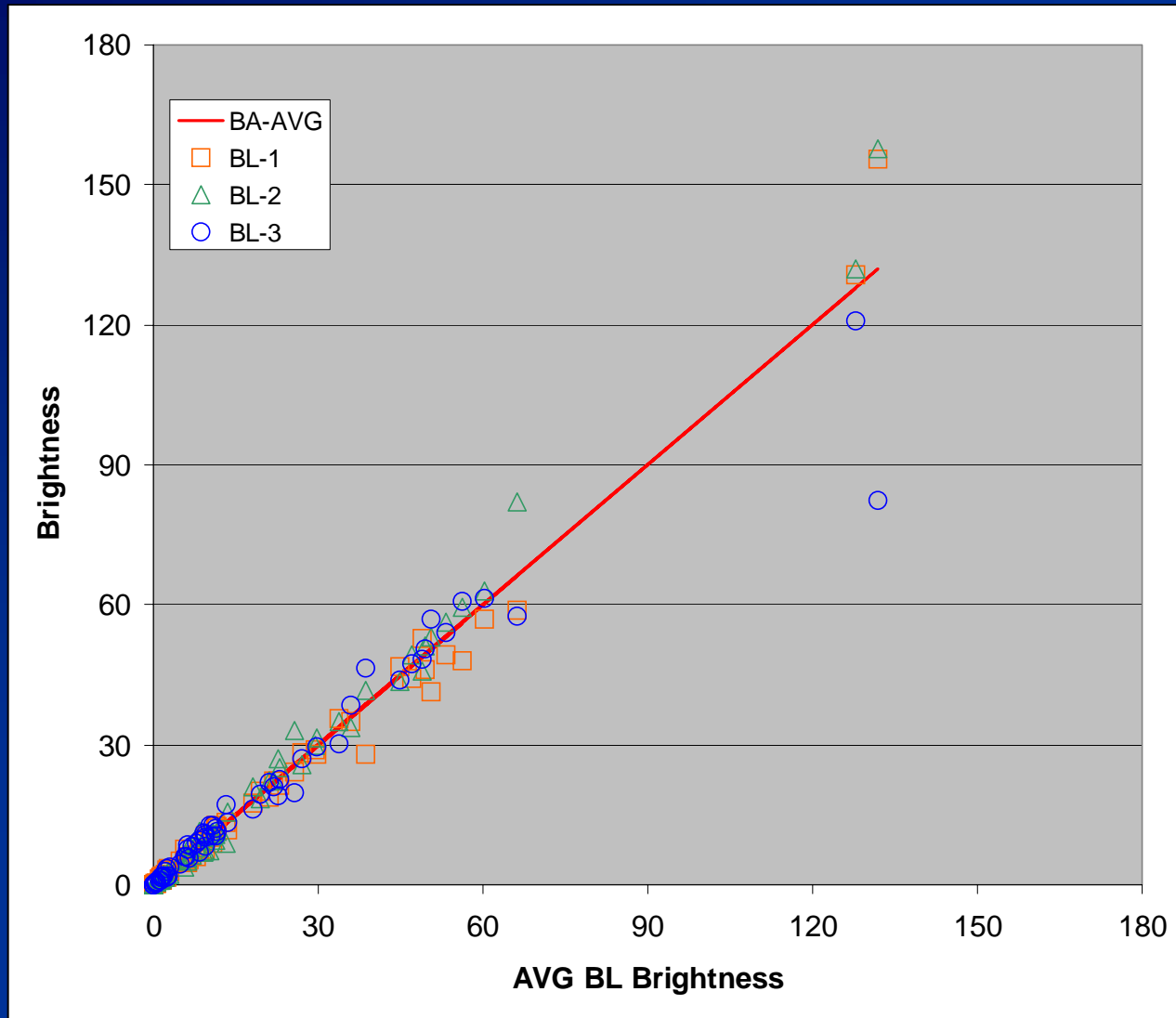


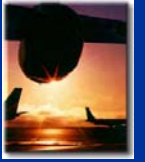
- Utilized standard sample process with baseline established using dip/drag method of developer application
- Evaluated four developer chambers and wand application methods at two locations
- Same penetrant process (level 4 PE) and chemistry use through out











- Samples gave repeatable performance
- Useful for measurement of changes in brightness as function of developer application methods



- Chamber a – Developer applied through linear diffuser located at top and bottom of chamber
- Chamber b – Developer applied from circular diffuser located at top and bottom of chamber
- Chamber c – Developer applied from circular diffuser located at top of chamber
- Chamber d – Developer applied from two nozzle diffusers located at bottom of chamber
- Manual spray – Low pressure, high volume manual application
- Dip/drag – Hand application of individual samples. Used for baseline measurements.



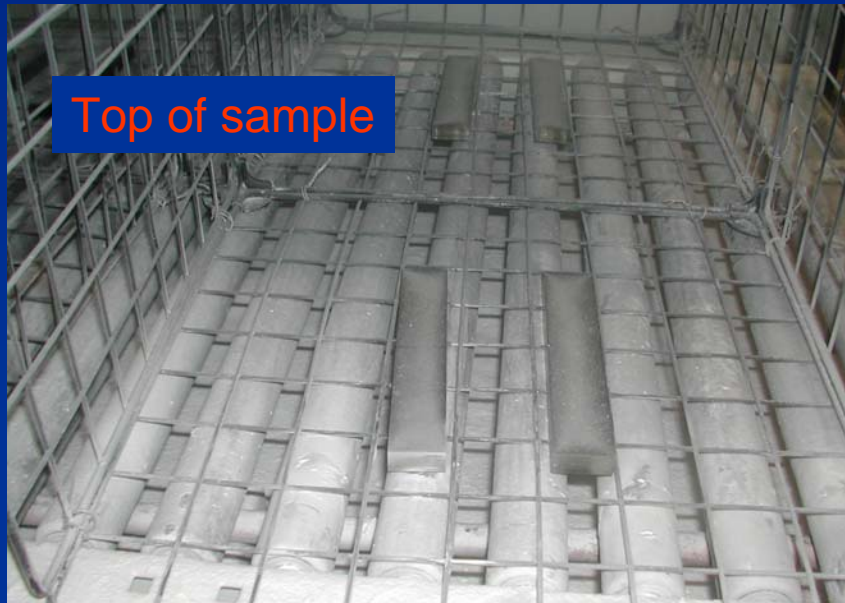


- Developer applied through linear diffusers located at top and bottom of chamber
- Developer time of 20 or 60 sec followed by 2 min dwell, 1 min evacuation and removal at 5 min
- Samples placed with cracks in up or down position

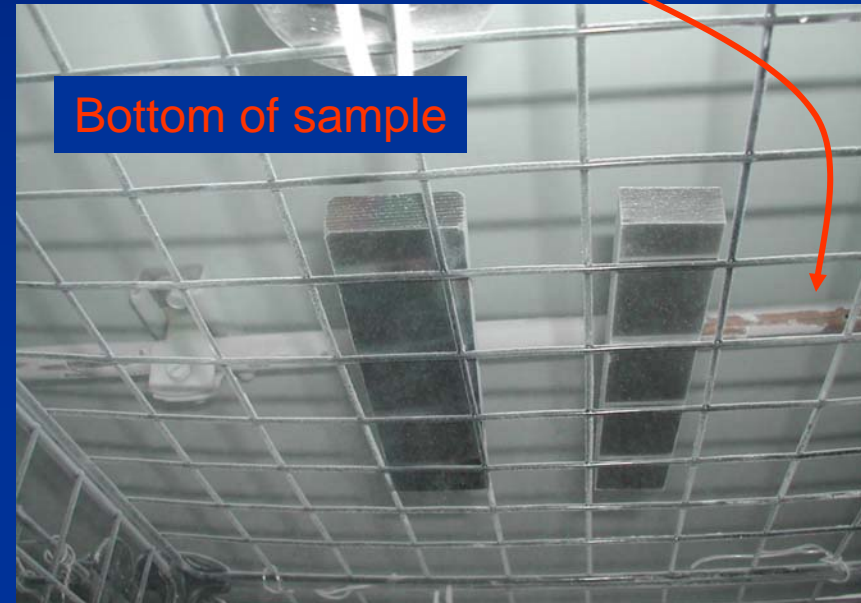


Samples prior to removal

Linear diffusers



Top of sample

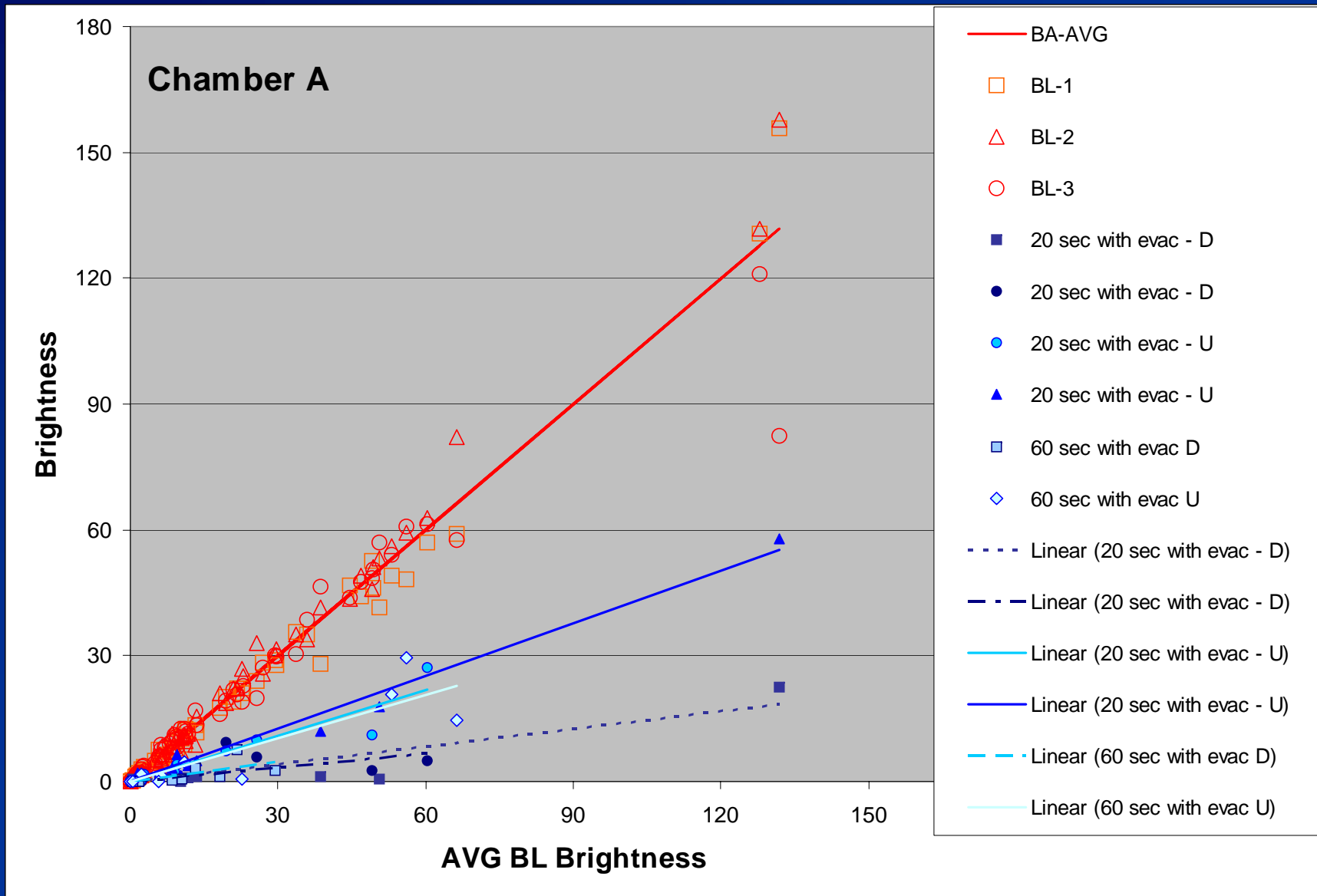


Bottom of sample



- New developer added to pot prior to study
- Run 8 – Samples placed in up or down position. Developer application for 20 sec.
- Run 10 – Samples in up or down position. Developer application for 60 sec.
- Run 12 – Samples placed in down or up (opposite of Run 8) position. Developer application for 20 sec.





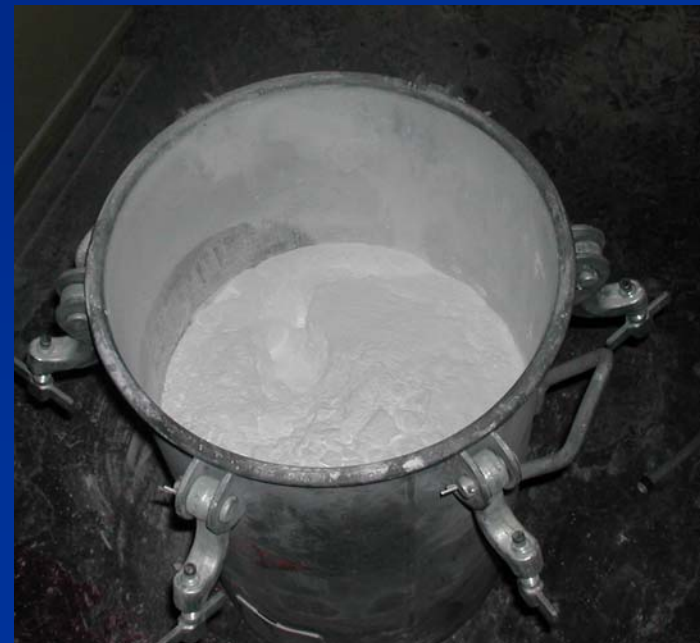
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Chamber B Characterization





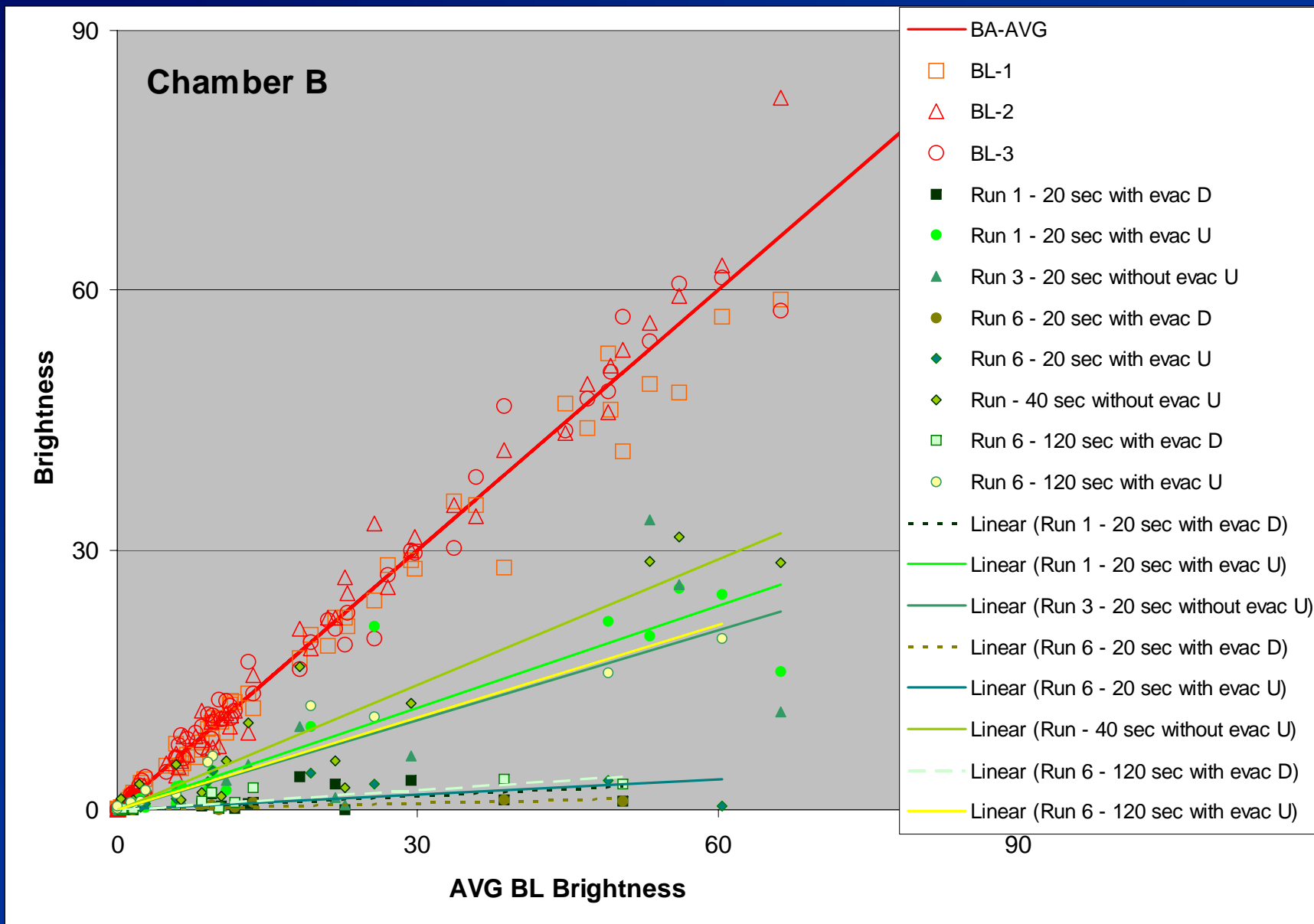
- Pressure pot with new developer added prior to study
- Circular diffusers at top and bottom of chamber
- Evacuation in upper, center region of chamber

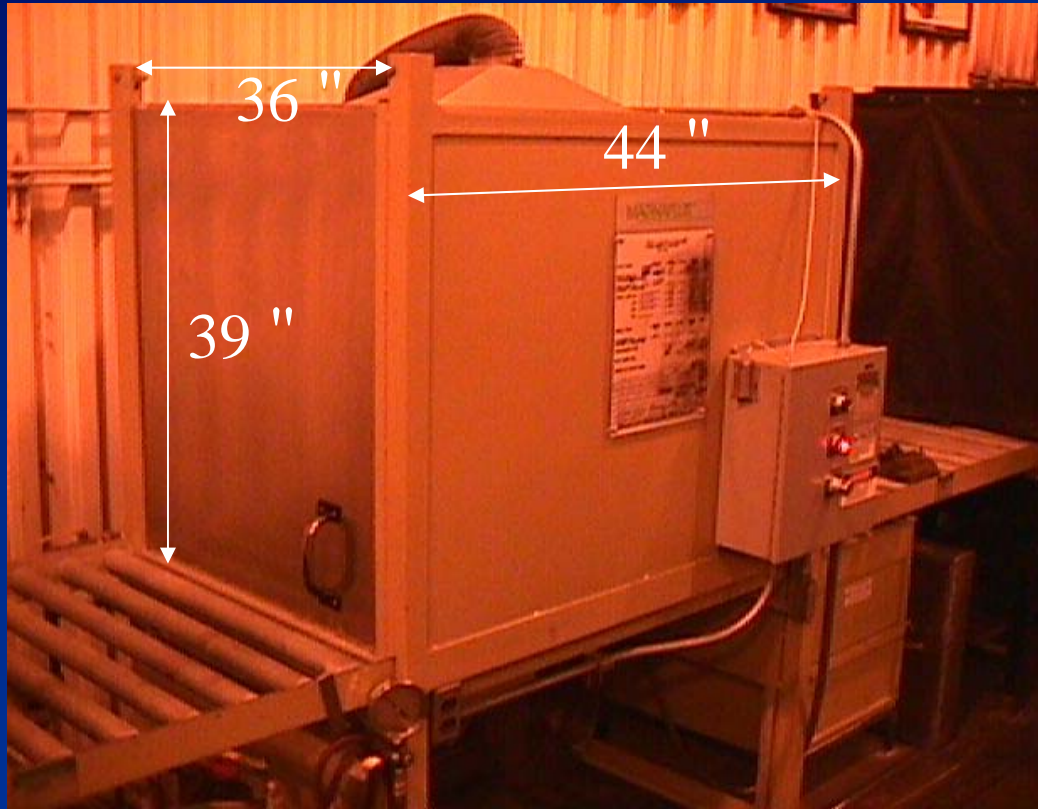




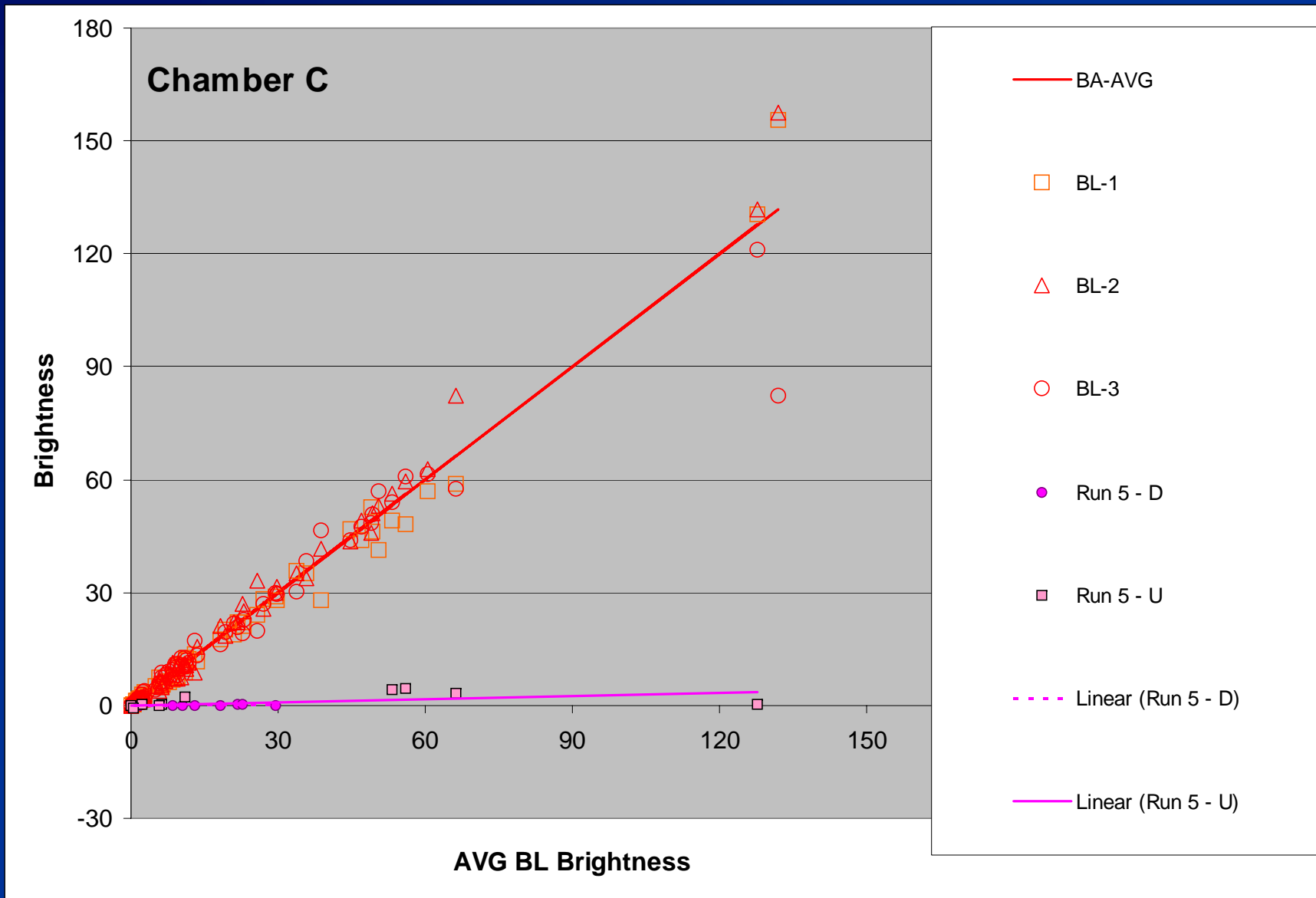
- 20 sec of developer application followed by 3.5 min dwell and 2 min evacuation
- Other runs included:
 - 20 sec without evac
 - 40 sec without evac
 - 120 sec with evac







- Circular diffuser located in top of chamber
- 120 sec of developer followed by 110 sec dwell and evacuation of 60 sec



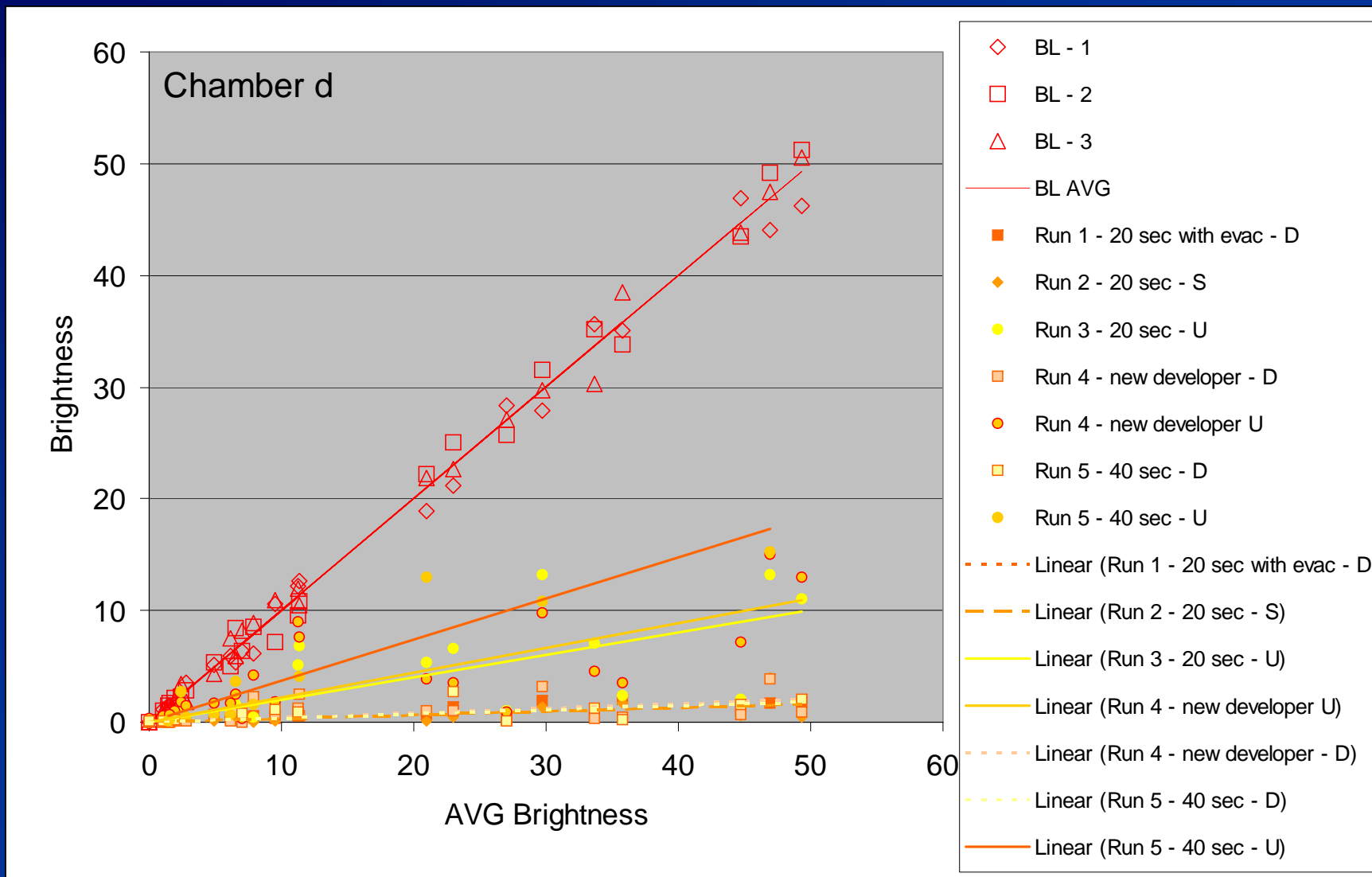
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Chamber D Characterization



- Chamber contains two jets, at approximately $\frac{1}{4}$ and $\frac{3}{4}$ of the chamber length
- Jets located below rollers
- Typical operation of 5 sec developer application followed by 10 min dwell in chamber





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Manual Spray Application



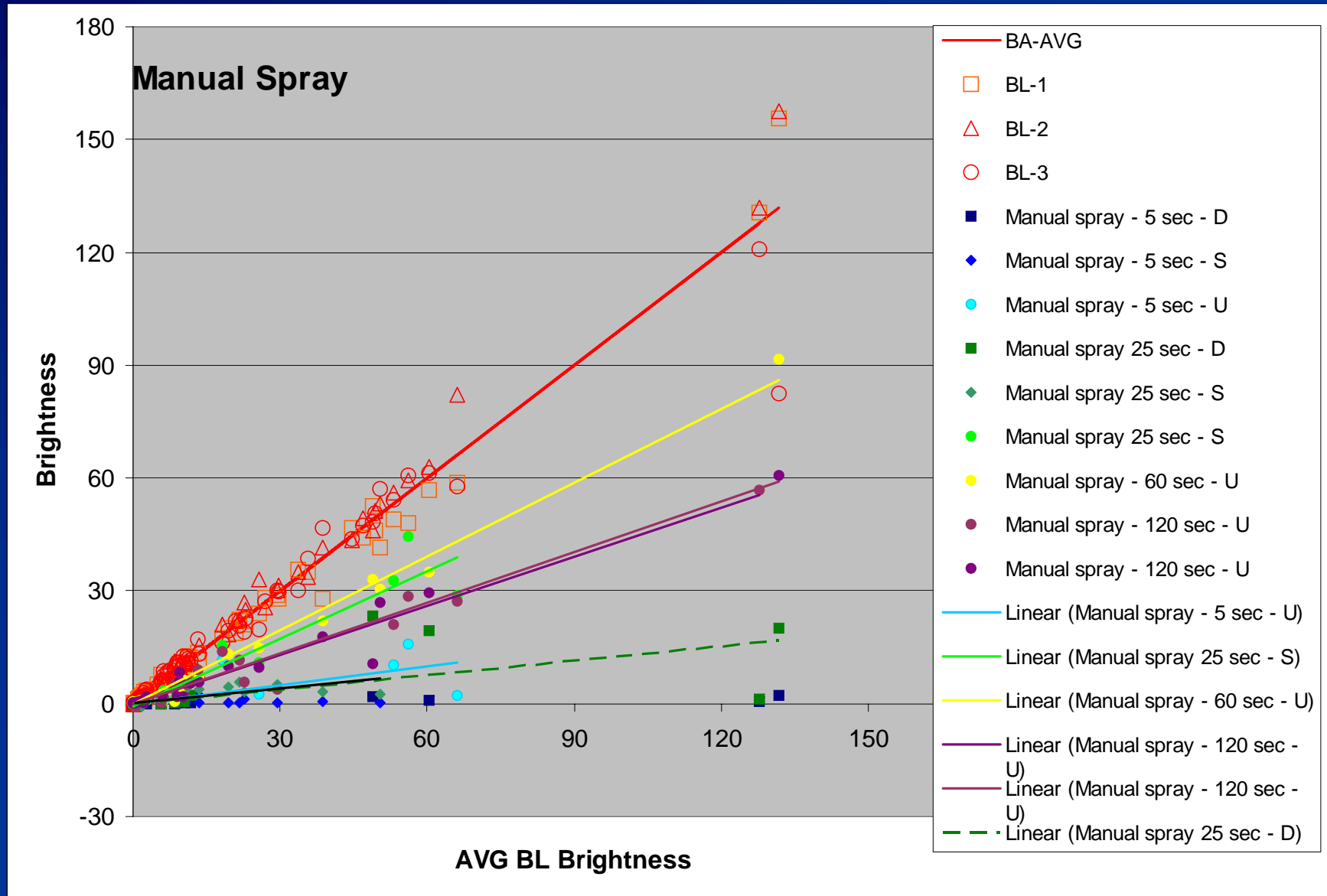
- Low pressure, high volume spray
- 5 and 25 sec runs completed using lobster cage with cracks in D, S or U position
- 60 and 120 sec runs completed with samples all in U position



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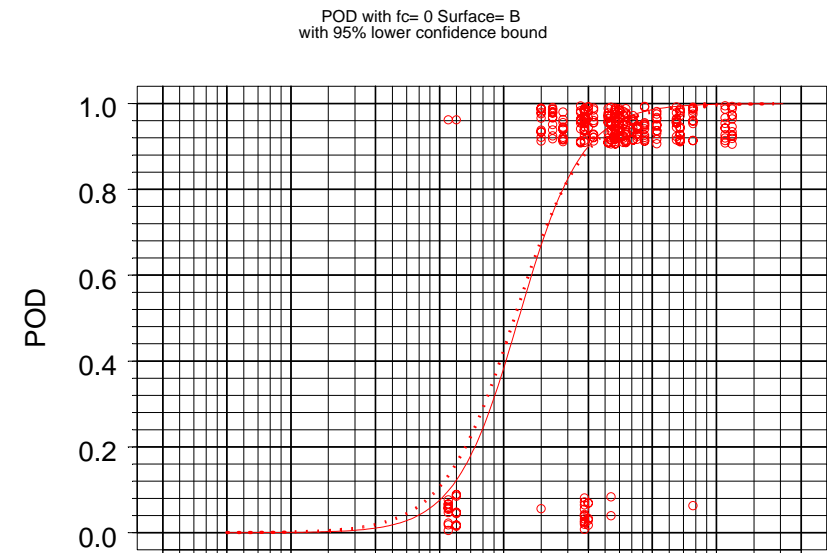
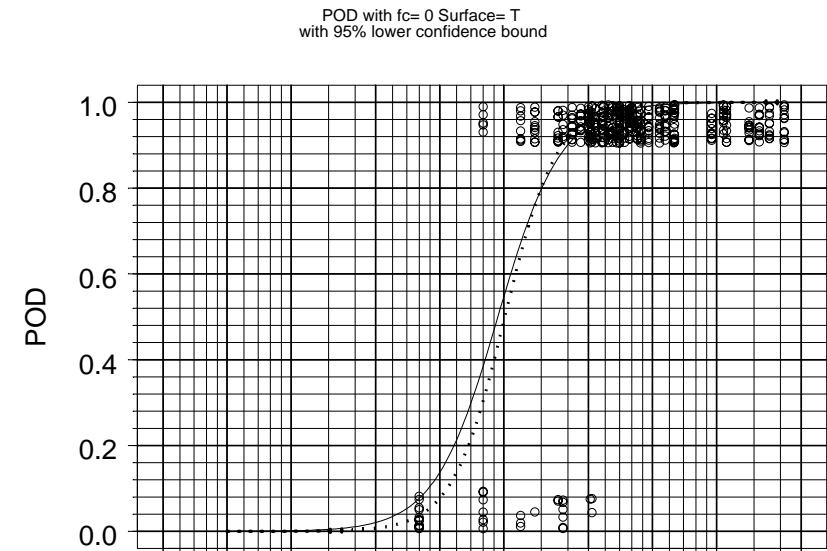
Manual Spray Application





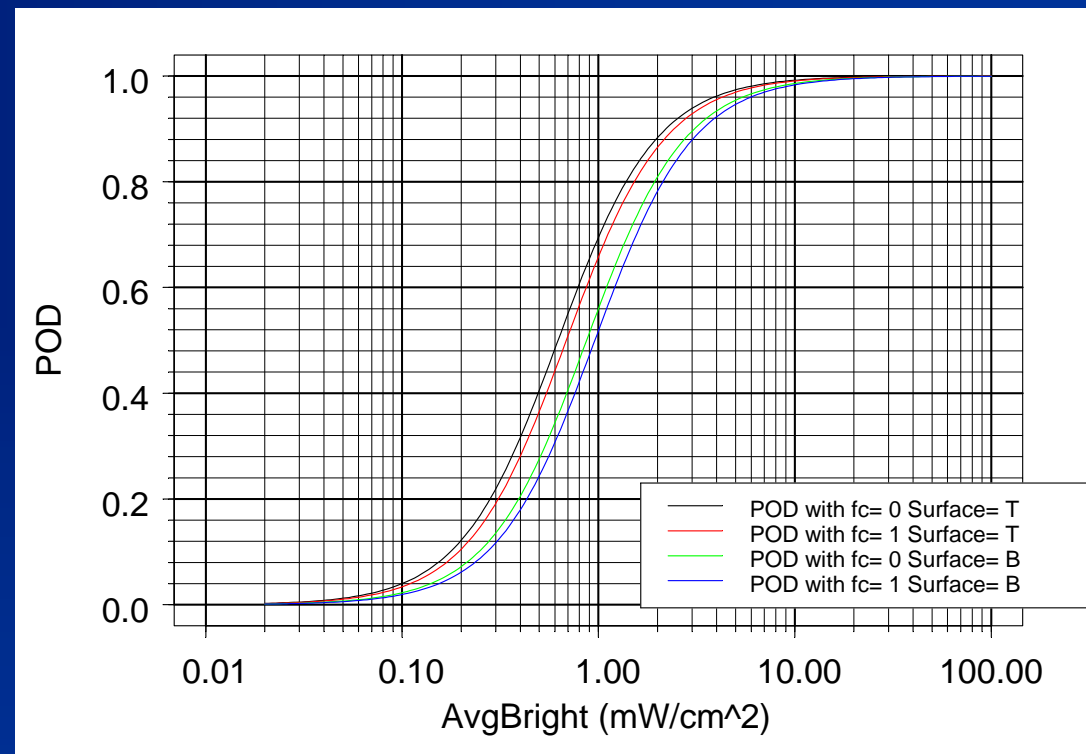


- Completed POD study which correlates brightness to detectability
- Used two sample sets, two inspectors under multiple UV intensity level, white light level combinations
- Evaluated indication location (top or bottom) of panel
- Significant differences can occur





- POD is correlated to brightness
- Increasing intensity from 1000 to 3000 did slightly improve POD but is within statistical error
- Increasing whitelight contamination led to reductions in POD 90/95 point
- Additional studies planned to determine when transition in detectability occurs





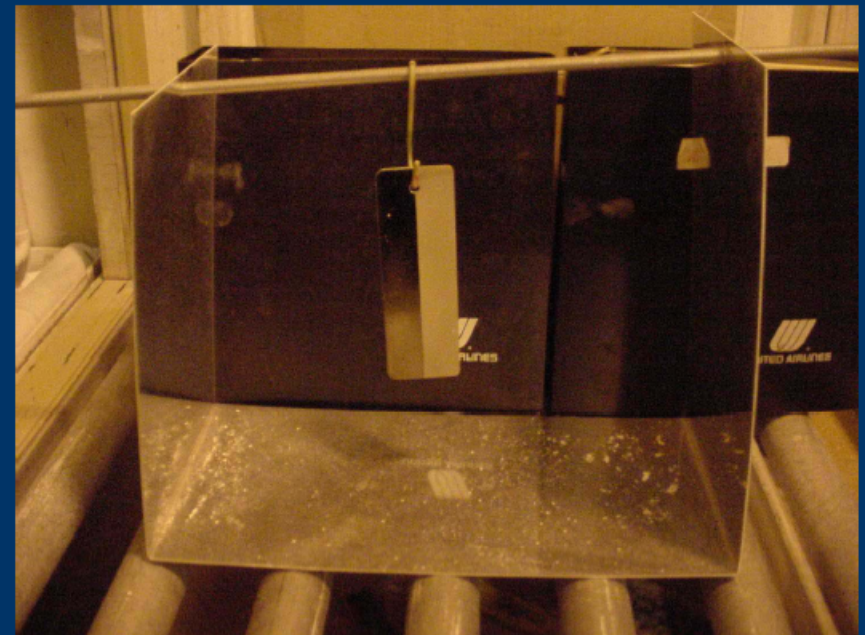
- Developer application by dip/drag yields brighter indication than with any of the developer chamber or wand application methods
- No indications were “lost” but detectability improves with brightness – optimal process will yield bright indications
- Improved understanding of the relationship between brightness and detectability would be beneficial
- Characterization method for typical chamber is needed



Ref: Tom Dreher ATA NDT Forum, 2004

- Utilized “worst case” configuration for the sample for comparison to dip/drag
- Digital camera used to record indication response for comparison

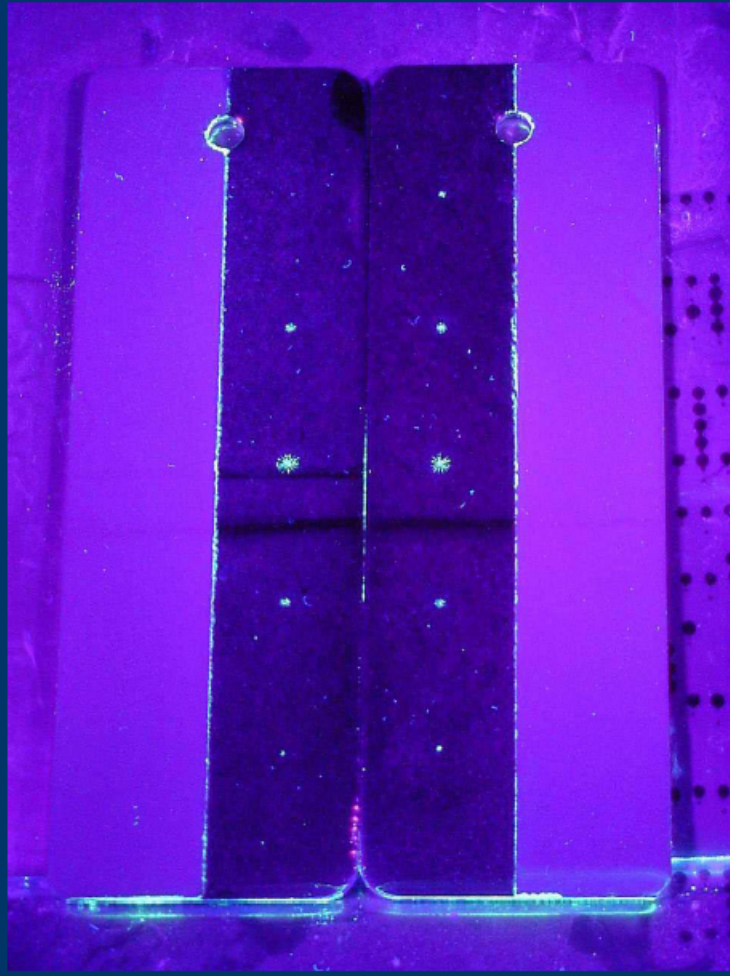
Vertical Run Set-up



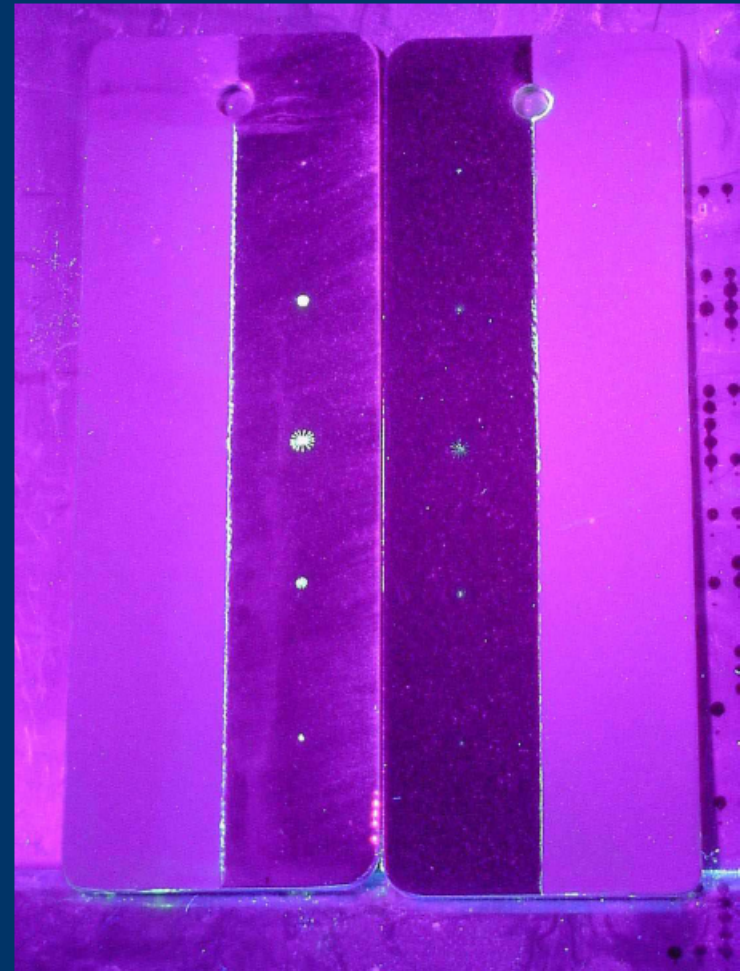


Ref: Tom Dreher ATA NDT Forum, 2004

KDS Panel 1st Baseline Horizontal Cabinet Run



Dip vs. Cabinet 1 After Vertical Run





- Developer application is critical to overall FPI performance
- Sample orientation matters
 - Avoid barriers that prevent direct application of the developer
 - Ensure chamber configuration or part handling fixtures (rollers, baskets, etc.) don't hamper application
 - No metal-to-metal contact
 - May require multiple trips through the chamber to ensure adequate coverage on all surfaces
- Additional studies underway to understand relationship between developer coverage and indication response